

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/717,679	KONG ET AL.	
Examiner	Art Unit	
Duy M. Dang	2624	

SEARCHED				
Class	Subclass	Date	Examiner	
382	232-236 275	5/18/2007	DD	
375	240.13 240			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East (uspto, derwen, pgpub, jpo, epo), see printouts	5/18/2007	DD
Inventor search (east and IEEE), see printouts		
IEEE search, see printouts		
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